

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10577919	LEE ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
MARCOS BATISTA	4134	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	335	5/6/2008	mb
370	342	5/6/2008	mb

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted with TA - Yogesh Aggarwal	5/6/2008	mb
Consulted with Lun-Yi Lao	5/6/2008	mb
Inventor's Name Seach	5/6/2008	mb
Consulted with Rafael Perez Gutierrez	11/5/2008	mb
East Search	11/5/2008	mb

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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